

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination CHATRENET, YVES	
		Examiner Rene Towa	Art Unit 3736	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2,590,055 A	03-1952	JOHANNES TIMMERMAN	73/379.01
*	B	US-3,752,144 A	08-1973	Weigle, Jr., Keith E.	600/587
*	C	US-4,711,448 A	12-1987	Minkow et al.	482/100
*	D	US-4,800,897 A	01-1989	Nilsson, Sten	600/595
*	E	US-4,883,066 A	11-1989	Widdoes et al.	600/587
*	E	US-5,174,402 A	12-1992	Chen, S. T.	177/245
*	G	US-5,398,696 A	03-1995	Wiley, Ronald L.	600/587
*	H	US-5,893,818 A	04-1999	Zahiri et al.	482/10
*	I	US-6,227,047 B1	05-2001	Livingston, J. Tracy	73/379.08
*	J	US-2001/0029342 A1	10-2001	Perrad et al.	600/587
*	K	US-2003/0148863 A1	08-2003	Thomas, Robert	482/122
*	L	US-7,104,926 B2	09-2006	Carlson, Alan	482/10
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.